

Search Notes

Application/Control No.

10/672,786

Examiner

Sheng-Jen Tsai

Applicant(s)/Patent under
Reexamination

DEFOUW ET AL.

Art Unit

2186

SEARCHED

Class	Subclass	Date	Examiner
711	103	7/12/2006	SJT
365	185.33	7/12/2006	SJT
711	165	7/12/2006	SJT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
711	103/165	7/12/2006	SJT
365	185.33	7/12/2006	SJT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East: "wear leveling" "block descriptor" "sorted list" "ascending order" "descending order"	7/12/2006	SJT
IEEE Explore: "wear leveling" "block descriptor" "sorted list" "ascending order" "descending order"	7/12/2006	SJT
Inspect: "wear leveling" "block descriptor" "sorted list" "ascending order" "descending order"	7/12/2006	SJT